Time-Domain Calibrated Measurements of Wideband Multisines Using a Large-Signal Network Analyzer


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Time-Domain Calibrated Measurements of Wideband Multisines Using a Large-Signal Network Analyzer

Mohammed El Yaagoubi, Guillaume Neveux, Denis Barataud, Tibault Reyevrand, Jean-Michel Nebus, Frans Verbeyst, Member, IEEE, Francis Gizard, and Jérôme Puech

Abstract—This paper presents a calibrated measurement technique that enables phase and magnitude measurements of wideband multisines. This study is based on the use of a large-signal network analyzer (LSNA) performing harmonic sub-sampling and a fine frequency grid (20 MHz) comb generator calibrated using a high-frequency 50-GHz equivalent-time sampling scope. This comb generator is used as a harmonic phase reference generator for the calibration of the LSNA.

The research presented in this paper improves the measurement setup having a good dynamic range (in the order of 60 dB) along with a fast measurement time and a small time base distortion. This paper extends the use of multimodal measurements, but it can be extended to higher microwave frequencies. The motivation of this study is to measure the multipactor phenomena effect in output RF multiplexers of satellite payloads.

Index Terms—Harmonic mixing, harmonic phase reference (HPR), large-signal network analyzer (LSNA), multisines, time-domain measurements.

I. INTRODUCTION

TODAY, time-domain LSNA measurements of nonlinear devices driven by continuous wave (CW) signals are well established. They have contributed to the experimental optimization of operation classes of transistors for high-efficiency amplifier designs [5]–[7]. LSNA measurements using high-impedance probes enable voltage measurements at internal nodes of monolithic microwave integrated circuits [8]–[10]. RF pulsed operation is also interesting for the characterization and modeling of high-power transistors, where thermal aspects pose additional challenges [11]. Mixer measurements have also been reported [12], [13]. In the previously mentioned research, the spectral components of the signals (carriers and harmonics or mixing products) must be set on a frequency grid having a minimum frequency step of 600 MHz and a maximum frequency step of 1.2 GHz. This is related to the frequency grids used for the calibration of the commercially available HPR generator.

Multisines having frequency spacing between a few tens of kilohertz and approximately 20 MHz are useful for the characterization of nonlinear devices. A quite simple two-tone signal is useful for linearity characterization of power amplifiers with memory [14]. It can also be useful for the fast load–pull...
measurements of power transistors [15]. Multisines are also useful for the purpose of behavioral modeling [16]. In that particular case, the required frequency grid is much lower than 600 MHz and must be accommodated to the frequency spacing of multisine test signals. Using the LSNA technique for multisine measurements, two main difficulties must be carefully examined.

First, a multisine phase calibrated generator must be used for the phase calibration of the LSNA. Solutions have been proposed for narrow-bandwidth multisine reference generators [17], [18]. However, wideband communication systems like satellite communication systems may require a bandwidth up to 250 MHz.

Second, when multisine RF signals have a bandwidth larger than 10 MHz, multiple harmonic mixing products occur in the down-converter stage and fall within the IF bandwidth of the instrument. This results in a quite complex frequency compressed IF spectrum. A way to accurately determine phase relationships between RF spectral components and IF scrambled spectral components has been proposed in [19]. It consists in measuring several narrow bandwidths, which are carefully interleaved. Applying spectral stitching [20], phase relationships between tones of adjacent bandwidths can be extracted. Nevertheless, this solution is not very straightforward and suffers from errors such that the uncertainty of the phase increases when moving toward both edges of the modulation frequency range.

In this section, we present a more straightforward technique, which is based on the use of a new HPR generator having a 20-MHz frequency grid. This reference phase generator has been calibrated by NMDG using an equivalent-time sampling scope. It can be argued that a finer frequency grid would have been better, but we found that 20 MHz was a good compromise for our application, which is the characterization of wideband 80-MHz multisines. This signal is very appropriate to study the multipactor effect in satellite payloads. As a consequence, in this paper, we propose to use a new HPR generator, which consists of a multisine covering the entire bandwidth (20 MHz–4 GHz) with a 20-MHz frequency spacing. The proposed technique is similar to the one reported in [21] and [22]. The technique presented here is a sampler-based technique, while the technique reported in [21] and [22] is a mixer-based technique. In mixer-based techniques, the different tones of the signals are sequentially measured. This technique requires an addition fifth channel connected to a harmonic phase generator for phase relationship measurements [7]. In sampler-based techniques, all the tones of interest are measured simultaneously.

In Section II, we give an overview of the basic problems encountered when wideband multisines are measured using the LSNA. The proposed approach for wideband multisine measurements is then explained.

Section III is dedicated to the description of the specific new HPR generator and its use for LSNA calibration. The HPR generator calibration procedure is also explained.

In Section IV, some measurement results are shown and discussed. To conclude, the future use of our calibrated setup is highlighted for multipactor characterization in satellite payloads.
Fig. 3 illustrates the RF to IF frequency translation and compression mechanisms when the input RF signal at Point C is now composed of the first three harmonics of an RF tone at a frequency $f_{RF}$.

The second graph of the Fig. 3 represents, at Point B, the spectrum of the strobe signal required for the sub-sampling process. As shown, the spectrum is a comb signal with a frequency spacing $f_{f_{RF}N}$ ($f_{f_{RF}N} = 19.6$ MHz in the numerical example of Fig. 3)

At Point D, a wide spectrum resulting from multiple mixing products between the RF spectral components and the local oscillator (LO) spectral components is obtained.

At Point E, we get a low-pass filtered IF spectrum, which is a low-frequency copy of the RF input spectrum. In the numerical example of Fig. 3, the frequency $f_{IF}$ of the filtered spectrum is equal to 0.4 MHz. The frequency $f_{IF}$ is the result of the mixing between $f_{RF}$ ($f_{RF} = 1$ GHz) and $N f_{f_{RF}N}$ ($f_{f_{RF}N} = 19.6$ MHz with $N = 51$ ($N = f_{f_{RF}N} = 51 \times 19.6$ MHz). The frequency $2 f_{IF}$ of the filtered spectrum is equal to 0.8 MHz and is the result of the mixing between $2 f_{RF}$ ($2 f_{RF} = 2$ GHz) and $2 N f_{f_{RF}N} = 1.9992$ GHz with $N = 51$ ($2 \times N = f_{f_{RF}N} = 2 \times 51 \times 19.6$ MHz).

As depicted in Fig. 1, the filtered IF signal is then digitized using high-dynamic range ADCs (50 MHz; in our case, 14 bits). The maximum sub-sampling frequency $f_{f_{RF}N}$ of the LSNA is in the order of 25 MHz. The IF low-pass filter bandwidth is in the order of 10 MHz.

Fig. 3. RF to IF frequency translation and compression principle.

Fig. 4. Block diagram of the LSNA system used for CW measurements.

This instrument can be used to measure periodic microwave signals.

A block diagram of the complete LSNA test bench including two bidirectional couplers is depicted in Fig. 4.

The basic relationships linking the measured data and the error corrected data of a two-port device are described as follows:

$$
\begin{pmatrix}
\alpha_1 \\
\alpha_2 \\
\beta_1 \\
\beta_2
\end{pmatrix} = \left[K_i\right] e^{j\phi_K} \times
\begin{pmatrix}
1 & \beta_1^* & 0 & 0 \\
\gamma_1 & \delta_1 & 0 & 0 \\
0 & 0 & \alpha_2^* & \beta_2^* \\
0 & 0 & \gamma_2 & \delta_2
\end{pmatrix} \times
\begin{pmatrix}
\alpha_1 \\
\beta_1 \\
\alpha_2 \\
\beta_2
\end{pmatrix}.
$$

Indices 1 and 2 represent the device port number, while $i$ is the frequency index. The relative error coefficients $\beta_1$, $\gamma_1$, $\delta_1$, $\alpha_2$, $\beta_2$, $\gamma_2$, $\delta_2$, and the absolute error terms $\left[K_i\right]$ and $\phi_K$ must be determined by a calibration procedure. As mentioned in Section I, this paper will not focus on the determination of $\beta_1$, $\gamma_1$, $\delta_1$, $\alpha_2$, $\beta_2$, $\gamma_2$, $\delta_2$, and $\left[K_i\right]$ using well-known SOLT, TRL, or LRRM relative calibrations and absolute power calibration. Instead, this paper focuses the determination of the term $\phi_K$ that requires a phase-calibration step, which is the most problematic for the time-domain measurements of wideband multisines. The phase calibration consists of determining the phase relationships between the RF components ($f_{RF}$, $2 f_{RF}$, $3 f_{RF}$, ... , $n f_{RF}$) and the corresponding IF images ($f_{IF}$, $2 f_{IF}$, $3 f_{IF}$, ... , $n f_{IF}$) shown in Fig. 5.

For that purpose, the phase relationships ($\theta_2 - \theta_1$) between $f_{RF}$ and $2 f_{RF}$, ($\theta_3 - \theta_1$) between $f_{RF}$ and $3 f_{RF}$, and ($\theta_n - \theta_1$) between $f_{RF}$ and the $n$th harmonic of $f_{RF}$ must be perfectly known. $\theta_1$ is an arbitrary phase reference, which can be set to 0. As a consequence, an HPR generator must be used and connected at plane 2 ($P_2$ in Fig. 4) for the phase calibration of the setup. This is illustrated in Fig. 6. During this phase calibration, the phase relationships ($\theta_2' - \theta_1'$), ($\theta_3' - \theta_1'$), and ($\theta_n' - \theta_1'$) are measured and error correction terms ($\theta_2' - \theta_2$), ($\theta_3' - \theta_3$), and ($\theta_n' - \theta_n$) can be extracted.

The frequency $f_0$ of the RF sinusoidal signal driving the HPR generator input can be tuned between 600 MHz–1.2 GHz. Therefore, it generates harmonic
components at $f_0$, $2f_0$, $3f_0$, ..., $Nf_0$. $f_0$ is tuned such that $k/f_0$ is exactly equal to $f_R$, $k$ is an integer and $f_R$ is the frequency of interest. The sampling frequency $f_{sam}$ is generally tuned close to 20 MHz and must remain exactly the same during the calibration procedure and the device-under-test measurements. The phase values $\theta_1$, $\theta_2$, and $\theta_3$ at frequencies $f_0$, $2f_0$, and $3f_0$, generated by the classical HPR generator, are perfectly known. Measuring $\theta_1' \circlearrowleft$, $\theta_2'$, and $\theta_3'$ during the phase-calibration procedure enables the determination of the value of $\varphi_K$ expressed in (1) and depicted in Fig. 5. The values of $\varphi_K$ are deduced from the following:

$$\begin{align*}
\varphi_K &= \theta_1' - \theta_1, & \text{for } i = 1 \Leftrightarrow f = f_0 \\
\varphi_K &= \theta_2' - \theta_2, & \text{for } i = 2 \Leftrightarrow f = 2f_0 \\
\varphi_K &= \theta_3' - \theta_3, & \text{for } i = 3 \Leftrightarrow f = 3f_0.
\end{align*}$$

When the above sub-sampling technique is applied to the measurement of modulated microwave signals, having modulation bandwidths higher than 20 MHz, things become much more complicated. Effectively, in that case, descrambling techniques of the measured IF spectral components are necessary after downconversion.

In the following, a periodic modulated signal is represented by a multisine having a bandwidth larger than 20 MHz. If such a signal is applied to the RF input (Point C) depicted in Fig. 1, the RF to IF conversion process performed by the LSNA is shown in Fig. 7. Only spectral components falling in the 10-MHz bandwidth of the IF filter are measured by the ADC.

In Fig. 7, the IF spectrum is the result of multiple $f^N_{IF}$ mixing products of the $M$th RF frequency ($f_M$) and the $N$th harmonic of $f_{sam}$. As an example, dotted lines in Fig. 7 illustrate double mixing of $f_3$ and $f_2$ with two successive harmonics of $f_{sam}$. Thus, the IF spectrum does not directly provide a low-frequency copy of the RF signal. Since the IF spectral components are scrambled, a descrambling technique is then required, as explained in [19].

However, the main problem lies in the phase-calibration procedure of the system for such wideband signal measurements. We proposed a method of performing a phase calibration using a narrowband multisine reference generator to perform wideband measurements of interleaved IF signals [20].

This method is complex and it suffers from propagation of errors such that the uncertainty of the phase increases when moving toward both edges of the modulation frequency range. A solution has been presented in [23] to address this problem using a pulsed modulation of the $f_{IF}$ output signal to capture samples of the RF signal at very low frequencies. To avoid adding another modulation module in the LSNA, in this paper we propose another solution using an appropriate multisine reference generator for the calibration of the setup. This reference generator is a multisine having a fine frequency grid, which is 20 MHz for our work reported here. This is now presented in Section III.
III. PRESENTATION OF THE PROPOSED METHOD

A. Description of the Principle

The key idea is, in fact, quite simple. It uses the LSNA for multisine measurements in the same manner as it is used for CW measurements. For CW measurements, we consider the carrier frequency and its harmonics \( f_{\text{RF}}, 2f_{\text{RF}}, 3f_{\text{RF}}, \ldots, Nf_{\text{RF}} \) during both LSNA calibration and device-under-test measurement. It means that a phase reference generator providing exactly \( f_{\text{RF}} \) and its harmonics is required for the phase-calibration step. The microwave source at \( f_{\text{RF}} \) and the synthesizer providing the strobe signal for harmonic sub-sampling are synchronized using a common 10-MHz reference signal. The sampling frequency \( f_{\text{IFc}N} \) is carefully chosen such that one of its harmonics \( Nf_{\text{IFc}N} \) is very close to \( f_{\text{RF}} \) [2]. Therefore, a well-conditioned frequency compression mechanism is achieved. Once the sub-sampling frequency \( f_{\text{IFc}N} \) is carefully tuned, it remains constant during both phase calibration and measurement.

The same process is used for multisine measurements having, for example, a 20-MHz frequency grid.

This is described in Fig. 8, where the 60-MHz bandwidth RF signal consists of four tones with 20-MHz frequency spacing. It has a 1.63-GHz center frequency and a 10-MHz envelope frequency. The filtered IF image signal also consists of four tones. It has a 0.815-MHz center frequency and a 5-kHz envelope frequency. The \( f_{\text{IFc}N} \) frequency is tuned to 20.01 MHz for this configuration.

In such conditions, the phase calibration is performed using a new HPR generator providing harmonics of a 20-MHz sinewave, which corresponds to the tone spacing of the microwave multisine that we want to characterize. We have built this new phase reference generator combining a 20-MHz synthesizer, an amplifier, a step recovery diode, and a differentiator, as described in Section III-B.

It is very important to note here that the ADCs are triggered by a transistor–transistor logic (TTL) signal. The trigger frequency \( f_{\text{trig}} \) is linked to the fast Fourier transform grid \( f_{\text{FFT,grid}} \) used for spectral calculation

\[
f_{\text{trig}} = p \times f_{\text{FFT,grid}} (p: \text{integer}) \tag{3}
\]

with

\[
f_{\text{FFT,grid}} = \frac{f_{\text{ADC}}}{N_{\text{ADC}}} \tag{4}
\]

where \( f_{\text{ADC}} \) and \( N_{\text{ADC}} \) are, respectively, the sampling frequency of the ADCs (different from the sub-sampling frequency \( f_{\text{IFc}N} \) and the number of recorded samples of the ADCs. One must also make sure that the period of the trigger signal equals the IF envelope period \( T_{\text{IF,env}} \) or an integer multiple of this period

\[
T_{\text{trig}} = M \times T_{\text{IF,env}} (M: \text{integer}) \tag{5}
\]

with

\[
f_{\text{IF,env}} = q \times f_{\text{FFT,grid}} (q: \text{integer}), \tag{6}
\]

From (3), (5), and (6), \( M \) can be defined as

\[
M = \frac{p}{q} \tag{7}
\]

This trigger signal is synthesized with an arbitrary waveform generator phase locked with the 10-MHz reference generated by the multitone RF generator.

Both phase and measurement configurations of the setup are, respectively, shown in Figs. 9 and 10.

In the numerical example of Fig. 9, the sampling frequency \( f_{\text{ADC}} \) of the ADC is set to 25 MHz. The number of samples \( N_{\text{ADC}} \) is set to 25,000. This results in a 1-kHz frequency resolution.

The IF spectrum, which is an image of the RF spectrum, has four tones, as described in Fig. 8 at \( f_{\text{IFc}1} = 800 \text{ kHz}, f_{\text{IFc}2} = 810 \text{ kHz}, f_{\text{IFc}3} = 820 \text{ kHz}, \) and \( f_{\text{IFc}4} = 830 \text{ kHz} \) (\( \Delta f_{\text{IF}} = 10 \text{ kHz} \)). These four IF tones are the result of the harmonic mixing process realized, respectively, with the successive 80th, 81st, 82nd, and 83rd harmonics of \( f_{\text{IFc}N} \). The frequency \( f_{\text{IFc}N} \) is set to 20.01 MHz in that case. The envelope period of the IF signal is equal to 200 \( \mu \text{s} \) \( (T_{\text{IF,env}} = 200 \mu \text{s} \iff f_{\text{IF,env}} \approx 5 \text{ kHz}) \). Choosing \( p \) equal to 5 and \( M \) equal to 1 implies the use of a 200-\( \mu \text{s} \) trigger signal \( T_{\text{trig}} = 200 \mu \text{s} \approx f_{\text{trig}} = 5 \text{ kHz} \).

Fig. 11 shows a time-domain representation of the signal at the ADC output and a time-domain representation of the associated trigger signal.

The trigger signal ensures that the acquisition starting time is always the same in regard to the envelope of the signal (with the transition of the phase jitter of the trigger signal). This is a key point of this measurement system that this trigger signal remains the same during the calibration and measurement steps.
The ADC performs an over-sampling of the IF two-tone signal and outputs 25,000 voltage points sampled every 40 ns, as shown in the zoom time-domain representation of Fig. 11.

Using this technique, no scrambling occurs in the IF spectrum. The LSNA proceeds to an RF to IF multisine frequency translation and compression in the same manner as for a CW carrier and its harmonics.

**B. Description of the Phase Reference Generator**

The new HPR generator that has been built using parts of an microwave transition analyzer is described in Fig. 12.

This new HPR is based on the use of a step recovery diode driven by a low-frequency sinusoidal signal, of which frequency \( f_{\text{HPR}} \) is equal to the RF tone spacing \( (\Delta f_{\text{RF}}) \) of the multisine used for measurements. In our case, \( f_{\text{HPR}} \) is 20 MHz. A nonlinear transmission line is added at the output of the step recovery diode to reduce the duration of the pulse and, in particular, the falling time of the pulse such that the output RF frequency bandwidth increases. The new HPR generator includes a 16-dB attenuator to obtain the appropriate desired peak voltage to protect the sampling gate when performing the phase calibration of the LSNA.

The output spectrum of this HPR generator is a comb signal, which is repeated at every \( f_{\text{HPR}} \). At point B in Fig. 1, in the frequency domain, the output of the new HPR is represented by harmonic components at \( f_{\text{HPR}}, 2f_{\text{HPR}}, 3f_{\text{HPR}}, \ldots, Mf_{\text{HPR}} \).

**C. Calibration Procedure of the Phase Reference Generator**

The HPR has been calibrated on a dense 20-MHz frequency grid up to 4 GHz by NMDG using a 50-GHz sampling oscilloscope. The measurement setup is described in Fig. 13.

It should be noticed that normally the 20-MHz excitation signal is used both as an input signal of the new HPR and as a trigger signal of the equivalent-time oscilloscope using a power splitter. However, to use exactly the same setup as during the phase calibration of the LSNA (which does not require a trigger signal), but a common 10-MHz reference signal), the setup is adapted such that the amplified 10-MHz reference signal of the CW synthesizer is used to trigger the sampling oscilloscope.

A 10-dB attenuator is added to the new HPR to avoid any nonlinearities introduced by the 50-GHz sampling oscilloscope.
Afterwards, the 10-dB attenuator is deembedded based on its two-port $S$-parameters.

As the maximum frequency of the HPR is 4 GHz, magnitude and phase distortion of the 50-GHz sampling oscilloscope can be reasonably neglected [3], [4]. However, one must deal with errors due to the time base distortion and time base drift of the sampling oscilloscope. The offset and gain error of the sampling oscilloscope is eliminated by performing the built-in plug-in calibration up front, while the jitter is neglected. Indeed, assuming a symmetrical probability density function of the jitter, it is known that the jitter does not introduce any phase distortion [23]. However, it has a low-pass effect on the amplitude. Since only the phase information is used, this effect is not compensated for and, as such, the amplitude characteristic shown in Fig. 14 includes the low-pass effect of the jitter.

The time base distortion is estimated [25] using a 100-ns time window, corresponding to two periods of the 20-MHz excitation signal.

In our experience, the known time base discontinuities are equal to 4 ns. Reference [26] is used to compensate for this distortion as part of the measurement of the pulse. Using two periods, one can verify if this correction is appropriate because one out of two spectral lines should be at the noise level after time base compensation.

Using the amplified 10-MHz reference signal of the synthesizer instead of splitting the 20-MHz excitation signal, it was found that it is essential to estimate and compensate the time base drift before averaging the measured pulse. Averaging is required to reduce the uncertainty on the measured phase of each spectral component.

Fig. 15 shows that the fall time of the generated pulse equals 50 ps and indicates that spectral components are present up to 20 GHz.

As a sanity check, the obtained phase of each spectral component is compared to the one obtained when the 20-MHz excitation is also used as a trigger signal, resulting in a less pronounced time base drift.

Finally, although being very small for the considered frequency range, the mismatch of both the HPR generator and the sampling oscilloscope is taken into account. At the same time, the 10-dB attenuator used to avoid nonlinearities of the sampling oscilloscope itself is deembedded. As the final result of the calibration, two files are provided. One file contains the phase in-
formation of the HPR generator on a 20-MHz grid up to 4 GHz when terminated in 50 Ω. The other contains the mismatch information of the HPR generator obtained using a vector network analyzer. Both files are required during the phase calibration of the LSNA.

This HPR generator is used during the phase-calibration step of the LSNA, configured as described in Section III-A. The principle of the phase-calibration step is exactly the same as the one previously described in Section II. The phase relationships between all the frequency components $\left( f_{\text{HPR}}, 2f_{\text{HPR}}, 3f_{\text{HPR}}, \ldots, mf_{\text{HPR}} \right)$ at the output of the new HPR generator are known based on the above calibration procedure of the HPR generator itself.

IV. MEASUREMENT RESULTS

Two types of measurements will be examined for the two following applications:

- two-tone measurements for the intermodulation characterization of the power amplifier;
- three- and five-tone measurements to validate a possible future use for the multipactor characterization in multichannel satellite payloads.

A. Phase Measurements of Power Amplifier

Intermodulation Products

A 2-W output power 30-dB gain 50-Ω power amplifier at 1.6 GHz has been measured. The amplifier is excited by a two-tone signal generated by a Rohde & Schwarz SMU200A source, as sketched in Fig. 16. The tone spacing is equal to $\Delta f_{\text{RF}} = 20$ MHz.

The calibration procedure has been performed at four different frequencies $f_1 = 1.6$ GHz, $f_2 = 1.62$ GHz, $f_3 = 1.64$ GHz, and $f_4 = 1.66$ GHz corresponding to a 60-MHz total RF bandwidth.

Table I indicates the parameter settings for this two-tone characterization.

The configuration of the test bench is the same as the one used for the calibration procedure. Harmonics of carriers are not considered in this study.

The LSNA input range is fixed for all input powers, resulting in a dynamic range of 52 dB. If desired, this dynamic range can be improved by increasing the number of acquisition points $N_{\text{ADC}}$.

Fig. 17 shows the measured power characteristics of the amplifier under test driven by a two-tone signal.

Fig. 18 represents the incident wave $a_1$ at $f_1 = 1.62$ GHz, $f_2 = 1.64$ GHz versus input power at $f_1 = 1.62$ GHz.

Fig. 19 represents the transmitted wave $b_2$ at the amplifier output at $f_1 = 1.62$ GHz and $f_2 = 1.64$ GHz versus input power.

Fig. 20 represents the variation of the magnitude and phase of the output voltage waveforms $b_2$ at $2f_1 - f_2 = 1.6$ GHz and $2f_2 - f_1 = 1.66$ GHz versus input power at $f_1 = 1.62$ GHz.

Due to the noise level, the phase is irrelevant for input powers at $f_1$ smaller than −6 dBm. The magnitude and phase information of $b_2$ at $2f_1 - f_2 = 1.6$ GHz and $2f_2 - f_1 = 1.66$ GHz can be very useful for very linear power amplifier design [24] and for the behavioral modeling of nonlinear devices with memory [25].

B. Phase Measurements of Multisines

Fig. 21 depicts the configuration of the measurement system to perform the phase measurements of a multisine, which consists of five tones with a 20-MHz ($\Delta f_{\text{RF}}$) tone spacing. The center frequency is 1.6 GHz. The resulting signal has a bandwidth of 80 MHz and is generated using the Rohde & Schwarz.

<table>
<thead>
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<td>$B_{\text{RF}}$</td>
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<td>$\Delta f_{\text{RF}}$</td>
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</tr>
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</tr>
<tr>
<td>$f_{\text{max}}$</td>
<td>5 kHz</td>
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Fig. 20. Principle of phase measurements of power amplifier intermodulations.

Fig. 21. Measured power characteristics of the amplifier under test.
source SMU200A. The magnitude of each tone is set to 1 V and the phase is set to 0°.

Table II indicates the modified parameter settings compared in Table I for the five-tone multisine measurement.

Fig. 22 shows LSNA measurement results of the signal b₂ present at plane $P_2$.

A 0.7-V peak voltage and a 7.2-ns pulselength are measured. It corresponds to a 13-dBm average power of the multitone RF source.

The linear phase variation observed in Fig. 22 versus frequency is due to the time delay introduced by the RF cable and connections between the SMU200A source and the reference plane $P_2$.

<table>
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<tr>
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<td>MHz</td>
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<td>$f_{fmc}$</td>
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<td>MHz</td>
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<tr>
<td>$M$</td>
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Fig. 22. LSNA measurements of a multisine composed of five tones with a 20-MHz tone spacing.

Fig. 23. LSNA measurements of a multisine composed of three tones with a 40-MHz tone spacing.

TABLE III
MODIFIED PARAMETER SETTINGs FOR THREE-TONE MULTISINE MEASUREMENT

<table>
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Fig. 24. System configuration for phase measurements of a five-tone multisine with the digital sampling oscilloscope.

The maximum voltage is now equal to 0.54 V, while the pulselwidth decreases to 5.2 ns for a given 13-dBm average output power of the multitone RF source. The linear phase variation versus frequency (Fig. 23) is also introduced by constant group delay of RF cables and connections between the SMU200A source and the reference plane P₁₉. It is very important to show the possibility to measure multisines with 40-MHz spacing, as it corresponds to real conditions in satellite payloads. It is also important to point the potential application to the characterization and the modeling of nonlinear devices.

C. Comparison Between LSNA and Digital Sampling Oscilloscope Measurements of Wideband Multisines

To compare the proposed approach described in this paper with digital sampling oscilloscope techniques, we have performed measurements of the five-tone signal previously characterized with a 40-GS/s–12-GHz bandwidth–8-bit digital sampling oscilloscope (Agilent Infinium 81204B), as depicted in Fig. 24.

Fig. 25 shows the digital sampling oscilloscope measurements of the five-tone multisine (80-MHz bandwidth) at the reference plane P₁₉. A 0.7-V peak voltage and a 7.9-ns pulsewidth are measured. It corresponds to an output power of the multitone RF source of –16.2 dBm.

The linear phase variation observed in Fig. 25 versus the frequency is due to the time delay introduced by the RF cable and connections between the SMU200A source and the reference plane P₁₉. Fig. 26 gives a comparison between the LSNA and digital sampling oscilloscope. A maximum magnitude difference of 0.08 V can be observed. A constant phase offset (in the order of 60°) is observed between the two measurements. It corresponds to different phase settings of the internal LO of the signal generator for two different experiments and measurements. The signal generator (SMU200A source) has been switched off and on between
LSNA measurements and oscilloscope measurements. If one removes this constant phase offset, one obtains the phase difference between the five tones versus the frequency plotted in Fig. 27.

For the LSNA measurements, a 1.8° maximum phase variation is observed around a mean value of 40.25°, while a 3.1° maximum phase variation is observed around a mean value of 40.6° for digital sampling oscilloscope measurements. This comparison between the direct oscilloscope measurements and the measurements performed with the LSNA calibrated with the new HPR generator demonstrates the effectiveness of the approach proposed in this paper to extract waveforms of wideband multisines.

V. Conclusion

A fully calibrated measurement technique that enables phase and magnitude measurements of wideband multisines has been presented in this paper. This measurement technique is based on the use of an LSNA with a phase-calibration procedure using a new standard calibration. This technique has been compared to a direct digital sampling oscilloscope measurement. The effectiveness of the LSNA measurement technique has been demonstrated.

20- or 40-MHz frequency grid multisines have been characterized and used as test signals as they correspond to channel frequency spacing in some satellite payloads.

The measurement principle has been validated for an 80-MHz bandwidth signal at the L-band. It can be extended to 250- or 500-MHz bandwidths at the Kα-band required for multipactor experiments in satellite payloads [27]. For that purpose, a very wideband source is needed in order to extend this study and to characterize the multipactor effect in OMUX satellite payloads.

Another topic of interest is the characterization of wideband high-power amplifiers in the order of 100 W. In such high-power amplifiers, memory effects will be more pronounced and, as a consequence, they require accurate magnitude and phase asymmetry characterization of intermodulation products.

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References


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